Search Notes

Application/Control No.	Applicant(s Reexamina
10/602 402	DEDDV ET

10/603,493

Examiner

Phallaka<sup>-</sup>Kik

Applicant(s)/Patent under
Reexamination
PERRY ET AL.
Art Unit

2825

SEARCHED			•
Class	Subclass	Date	Examiner
716	11	6/11/2005	PK
709	202,203	6/11/2005	PK
340	7.29	6/11/2005	PK
370	395.52	6/11/2005	PK
379	88.17	6/11/2005	PK
Above	updated	11/26/2005	PK
Above	new	11/26/2005	PK
Above	new	12/7/2005	PK
Above	updated	1/7/2006	PK
Above	updated	2/4/2006	PK
Above	updated	8/17/2006	PK
Above	new	8/17/2006	PK
Above	updated	3/1/2007	PK
Above	new	3/1/2007	PK

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
BRS (EAST)USPAT, USPGPUB Classes/Sub searched: 716/1-18; 709/all; 340/all; 370/all (see attached)	6/11/2005	PK
Above upaded and new search (see attached)	11/26/2005	PK
Above new search (see attached)	12/7/2005	PK
Above updated search (see attached)	1/7/2006	PK
Above updated search (see attached)	2/4/2006	PK
Above udpated and new search (see attached)	8/17/2006	PK
EPO, JPO,IBM TDB, Derwent (see attached)	6/11/2005	PK
IEE/IEEE Xplore (see attached)	12/7/2005	PK

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10/603,493	PERRY ET AL.
Examiner	Art Unit
Phaliaka Kik	2825

SEARCHED			
Class	Subclass	Date	Examiner
Above	updated	9/25/2007	PK
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
IEE/IEEE Xplore (see attached)	12/7/2005	PK
BRS (EAST) (updated and new search):USPAT, USPGPUBClasses/Sub searched: 716/1-18; 709/all; 340/all; 370/all (see attached)	3/1/2007	PK
IEE/IEEE Xplore (see attached)New search	3/1/2007	PK
BRS (EAST) (updated search):USPAT, USPGPUBClasses/Sub searched: 716/1-18; 709/all; 340/all; 370/all (see attached)	9/25/2007	PK
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